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Descrizione fisica	1 online resource (XIII, 588 p. 167 illus.)
Collana	Image Processing, Computer Vision, Pattern Recognition, and Graphics ; ; 10029
Disciplina	006.4
Soggetti	Artificial intelligence Pattern recognition Application software Database management Algorithms Data mining Artificial Intelligence Pattern Recognition Information Systems Applications (incl. Internet) Database Management Algorithm Analysis and Problem Complexity Data Mining and Knowledge Discovery
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	Includes index.
Nota di contenuto	Dimensionality reduction -- Manifold learning and embedding methods.-Dissimilarity representations -- Graph-theoretic methods -- Model selection, classification and clustering -- Semi and fully supervised learning methods -- Shape analysis -- Spatio-temporal pattern recognition -- Structural matching -- Text and document analysis. .
Sommario/riassunto	This book constitutes the proceedings of the Joint IAPR International

Workshop on Structural Syntactic, and Statistical Pattern Recognition, S+SSPR 2016, consisting of the International Workshop on Structural and Syntactic Pattern Recognition SSPR, and the International Workshop on Statistical Techniques in Pattern Recognition, SPR. The 51 full papers presented were carefully reviewed and selected from 68 submissions. They are organized in the following topical sections: dimensionality reduction, manifold learning and embedding methods; dissimilarity representations; graph-theoretic methods; model selection, classification and clustering; semi and fully supervised learning methods; shape analysis; spatio-temporal pattern recognition; structural matching; text and document analysis. .
